

**Search Notes**

Application/Control No.

10/695,834

Examiner

Ren L. Yan

**Applicant(s)/Patent under Reexamination**

ACKLEY ET AL.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
101	35		
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<i>above search</i>			
<i>updated 5/11/06 RY</i>			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference search print out		5/11/2006	RY